

| | | | | |
|-----------------------------------|--|-------------------------|---|--|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination 10/565,467 LUCAS ET AL. | |
| | | Examiner | Art Unit | Page 1 of 1 Christopher P. Schwartz 3657 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|-----|--|-----------------|--------------------|----------------|
| * | A | US-3,031,845 | 05-1962 | LUDWIG JOHN W | 60/632 |
| * | B | US-3,799,293 | 03-1974 | Howells et al. | 188/5 |
| * | C | US-4,553,644 | 11-1985 | Folch, Carlos M. | 188/72.4 |
| * | D | US-4,613,015 | 09-1986 | Skrzypek, James R. | 188/6 |
| * | E | US-4,753,074 | 06-1988 | Belart et al. | 60/548 |
| * | F | US-6,452,535 | 09-2002 | Rao et al. | 342/72 |
| * | G | US-6,850,156 | 02-2005 | Bloomfield et al. | 340/467 |
| * | H | US-7,114,873 | 10-2006 | Rastegar et al. | 404/6 |
| I | US- | | | | |
| J | US- | | | | |
| K | US- | | | | |
| L | US- | | | | |
| M | US- | | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.